

**Search Notes**

Application/Control No.

10/539,158

Examiner

Benjamin C. Lee

Applicant(s)/Patent under  
Reexamination

DETIG ET AL.

Art Unit

2612

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (Text search history printout)	5/10/2007	BZ